

**MEMS Die Attach Change for ADXL354, ADXL355, ADXL356, ADXL357**

**Qualification Results Summary  
of the ADXL354, ADXL355 New Die Attach**

<b>QUALIFICATION PLAN</b>			
<b>TEST</b>	<b>SPECIFICATION</b>	<b>SAMPLE SIZE</b>	<b>RESULTS</b>
Temperature Cycle (TC)*	JEDEC JESD22-A104	3 x 77	Pass
High Temperature Storage	JEDEC JESD22-A103	3 x 77	Pass
Random Drop	AECQ100 Test G5	3 x 39	Pass
Mechanical Shock - Unpowered	IEC 60068-2-27	3 x 39	Pass
Variable Frequency Vibration	MIL-STD883, M2007	3 x 39	Pass
Constant Acceleration	MIL-STD883, M2001	3 x 39	Pass

\*Preconditioning (per J-STD-020)

**MEMS Die Attach Change for ADXL354, ADXL355, ADXL356, ADXL357**

**Qualification Results Summary  
of the ADXL356, ADXL357 New Die Attach**

<b>QUALIFICATION PLAN</b>			
<b>TEST</b>	<b>SPECIFICATION</b>	<b>SAMPLE SIZE</b>	<b>RESULTS</b>
Temperature Cycle (TC)*	JEDEC JESD22-A104	3 x 77	Pass
High Temperature Storage	JEDEC JESD22-A103	3 x 77	Pass
Random Drop	AECQ100 Test G5	3 x 39	Pass
Mechanical Shock - Unpowered	IEC 60068-2-27	3 x 39	Pass
Variable Frequency Vibration	MIL-STD883, M2007	3 x 39	Pass
Constant Acceleration	MIL-STD883, M2001	3 x 39	Pass

\*Preconditioning (per J-STD-020)